

Notice of References Cited	Application/Control No. 10/766,035	Applicant(s)/Patent Under Reexamination ANDO ET AL.	
	Examiner Jeffrey D. Lane	Art Unit 2828	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,779,280	10-1988	Sermage et al.	372/45.01
*	B	US-6,282,345	08-2001	Schimpe, Robert	385/50
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Luxpop Index of refraction values and photonics calculations", available at http://www.luxpop.com , accessed Jan. 18, 2006
	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.